

# SPP3407B

## DESCRIPTION

The SPP3407B is the P-Channel logic enhancement mode power field effect transistors are produced using high cell density , DMOS trench technology.

This high density process is especially tailored to minimize on-state resistance.

These devices are particularly suited for low voltage application such as cellular phone and notebook computer power management and other battery powered circuits, and low in-line power loss are needed in a very small outline surface mount package.

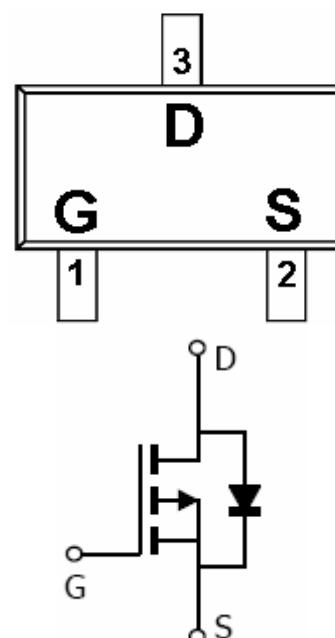
## FEATURES

- ◆ -30V/-4.0A,R<sub>DS(ON)</sub>= 70mΩ@V<sub>GS</sub>=- 10V
- ◆ -30V/-3.2A,R<sub>DS(ON)</sub>= 95mΩ@V<sub>GS</sub>=-4.5V
- ◆ Super high density cell design for extremely low R<sub>DS (ON)</sub>
- ◆ Exceptional on-resistance and maximum DC current capability
- ◆ SOT-23-3L package design

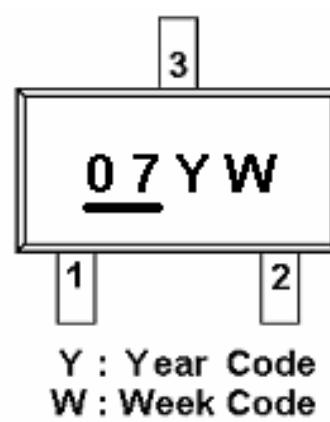
## APPLICATIONS

- Power Management in Note book
- Portable Equipment
- Battery Powered System
- DC/DC Converter
- Load Switch
- DSC
- LCD Display inverter

## PIN CONFIGURATION(SOT-23-3L)



## PART MARKING



**SPP3407B****PIN DESCRIPTION**

Pin	Symbol	Description
1	G	Gate
2	S	Source
3	D	Drain

**ORDERING INFORMATION**

Part Number	Package	Part Marking
SPP3407BS23RGB	SOT-23-3L	<u>0</u> 7YW

※ Week Code : A ~ Z( 1 ~ 26 ) ; a ~ z( 27 ~ 52 )

※ SPP3407BS23RGB : Tape Reel ; Pb – Free; Halogen – Free

**ABSOLUTE MAXIMUM RATINGS**

(TA=25°C Unless otherwise noted)

Parameter	Symbol	Typical	Unit
Drain-Source Voltage	V <sub>DSS</sub>	-30	V
Gate –Source Voltage	V <sub>GSS</sub>	±20	V
Continuous Drain Current(T <sub>J</sub> =150°C)	T <sub>A</sub> =25°C	I <sub>D</sub>	-3.6
	T <sub>A</sub> =70°C		-3.0
Pulsed Drain Current	I <sub>DM</sub>	-15	A
Continuous Source Current(Diode Conduction)	I <sub>S</sub>	-1.0	A
Power Dissipation	T <sub>A</sub> =25°C	P <sub>D</sub>	1.25
	T <sub>A</sub> =70°C		0.8
Operating Junction Temperature	T <sub>J</sub>	150	°C
Storage Temperature Range	T <sub>STG</sub>	-55/150	°C
Thermal Resistance-Junction to Ambient	R <sub>θJA</sub>	120	°C/W

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## ELECTRICAL CHARACTERISTICS

(TA=25°C Unless otherwise noted)

Parameter	Symbol	Conditions	Min.	Typ	Max.	Unit
<b>Static</b>						
Drain-Source Breakdown Voltage	V <sub>(BR)DSS</sub>	V <sub>GS</sub> =0V, ID=-250uA	-30			V
Gate Threshold Voltage	V <sub>GS(th)</sub>	V <sub>D</sub> =V <sub>G</sub> , ID=-250uA	-0.8		-2.5	
Gate Leakage Current	I <sub>GSS</sub>	V <sub>D</sub> =0V, V <sub>G</sub> =±20V			±100	nA
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	V <sub>D</sub> =-24V, V <sub>G</sub> =0V			-1	uA
		V <sub>D</sub> =-24V, V <sub>G</sub> =0V T <sub>J</sub> =55°C			-10	
On-State Drain Current	I <sub>D(on)</sub>	V <sub>D</sub> ≤-5V, V <sub>G</sub> =-10V	-10			A
Drain-Source On-Resistance	R <sub>DSS(on)</sub>	V <sub>G</sub> =-10V, ID=-4.0A		0.062	0.070	Ω
		V <sub>G</sub> =-4.5V, ID=-3.2A		0.085	0.095	
Forward Transconductance	g <sub>f</sub> s	V <sub>D</sub> =-5.0V, ID=-4.0A		10		S
Diode Forward Voltage	V <sub>SD</sub>	I <sub>S</sub> =-1.0A, V <sub>G</sub> =0V		-0.8	-1.2	V
<b>Dynamic</b>						
Total Gate Charge	Q <sub>g</sub>	V <sub>D</sub> =-15V, V <sub>G</sub> =-10V ID= -3.5A		10	18	nC
Gate-Source Charge	Q <sub>gs</sub>			1.6		
Gate-Drain Charge	Q <sub>gd</sub>			3.0		
Input Capacitance	C <sub>iss</sub>	V <sub>D</sub> =-15V, V <sub>G</sub> =0V f=1MHz		450		pF
Output Capacitance	C <sub>oss</sub>			95		
Reverse Transfer Capacitance	C <sub>rss</sub>			55		
Turn-On Time	t <sub>d(on)</sub>	V <sub>D</sub> =-15V, R <sub>L</sub> =15Ω ID=-1.0A, V <sub>GEN</sub> =-10V R <sub>G</sub> =6Ω		8	18	nS
	t <sub>r</sub>			8	18	
Turn-Off Time	t <sub>d(off)</sub>			25	50	
	t <sub>f</sub>			25	35	